

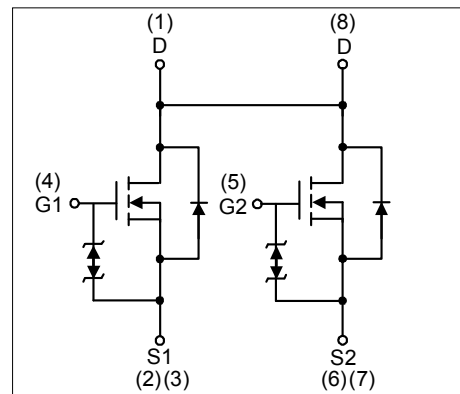
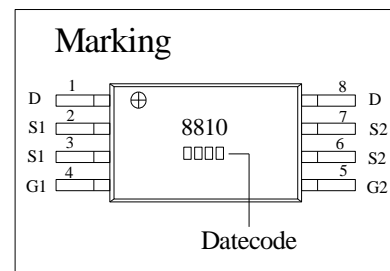
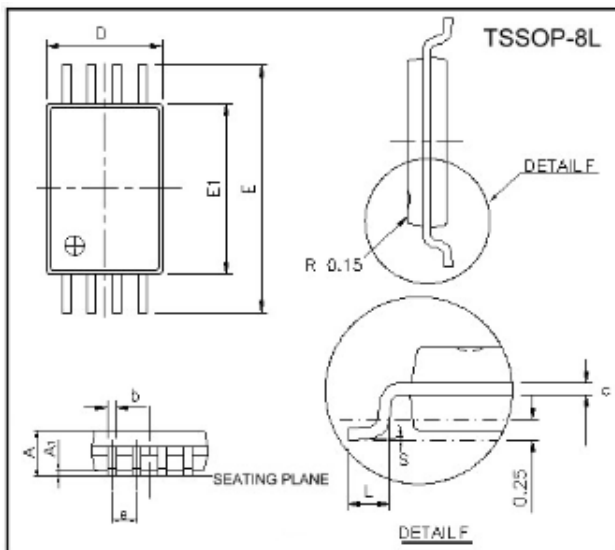
YGMOS Technology Crop.

20V Dual N-Channel Enhancement-Mode MOSFET 20V 双N沟道增强型 MOS管

VDS= 20V ID= 7.0A
ESD Protected : 2000V
RDS(ON), Vgs@4.5V, Ids@7.0A = 20mΩ
RDS(ON), Vgs@4.0V, Ids@7.0A = 22mΩ
RDS(ON), Vgs@3.1V, Ids@6.5A = 23mΩ
RDS(ON), Vgs@2.5V, Ids@6.5A = 25mΩ
RDS(ON), Vgs@1.8V, Ids@5.0A = 28mΩ
Features 特性

Advanced trench process technology 高级的加工技术
 High Density Cell Design For Ultra Low On-Resistance
 Specially Designed for Li ion battery packs use
 Designed for battery switch applications
 Battery Swicth, ESD protected

极低的导通电阻高密度的单元设计、专为锂电池设计、静电保护


Package Dimensions


REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	--	1.20	E1	4.3	4.5
A1	0.05	0.15	L	0.35	0.49
b	0.19	0.30	L1	1.35	1.75
c		0.13	e	0.65 REF.	
D	2.9	3.1			
E	6.2	6.6			

Maximum Ratings and Thermal Characteristics (TA = 25 °C unless otherwise noted) 25 °C 极限参数和热特性

Parameter 极限参数	Symbol 符号	Limit 范围	Unit 单位	
Drain-Source Voltage 漏源电压	V _{DS}	20	V	
Gate-Source Voltage 栅源电压	V _{GS}	± 12		
Continuous Drain Current 连续漏极电流	I _D	6.5	A	
Pulsed Drain Current 脉冲漏极电流	I _{DM}	24		
Maximum Power Dissipation 最大耗散功率	P _D	TA = 25 °C	2	W
		TA = 75 °C	0.64	
Operating Junction and Storage Temperature Range 使用及储存温度	T _J , T _{stg}	-55 to 150	°C	
Junction-to-Ambient Thermal Resistance (PCB mounted) 结环热阻	R _{θJA}	62.5	°C/W	

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Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typc	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	20	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=20V, V_{GS}=0V$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 12V, V_{DS}=0V$	-	-	± 10	μA
On Characteristics						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.5	0.85	1.5	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=4.5A$		15	20	$m\Omega$
		$V_{GS}=4.0V, I_D=4.5A$		16	22	$m\Omega$
		$V_{GS}=3.1V, I_D=4.5A$		17	23	$m\Omega$
		$V_{GS}=2.5V, I_D=4.5A$		20	25	$m\Omega$
		$V_{GS}=1.8V, I_D=3.5A$		22	28	$m\Omega$
Forward Transconductance	g_{FS}	$V_{DS}=5V, I_D=4.75A$	-	28	-	S
Dynamic Characteristics ^b						
Input Capacitance	C_{iss}	$V_{DS}=10V,$ $V_{GS}=0V,$ $F=0.2MHz$	-	750	-	pF
Output Capacitance	C_{oss}		-	117	-	pF
Reverse Transfer Capacitance	C_{rss}		-	99	-	pF
Switching Characteristics ^b						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=10V,$ $I_D=4.75A$ $V_{GS}=4.5V,$ $R_{GEN}=3\Omega,$	-	11.5	-	nS
Turn-on Rise Time	t_r		-	13	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	73	-	nS
Turn-Off Fall Time	t_f		-	34	-	nS
Total Gate Charge	Q_g	$V_{DS}=10V,$ $I_D=1.5A,$ $V_{GS}=4.5V$	-	12	-	nC
Gate-Source Charge	Q_{gs}		-	0.6	-	nC
Gate-Drain Charge	Q_{gd}		-	3.6	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S=1.7A$	-	0.8	1.2	V
Maximum Body-Diode Continuous	I_S	-	-	-	2.5	A

Notes

- Pulse Test: Pulse Width < 10us, Duty Cycle < 1%.
- Guaranteed by design, not subject to production testing.
- Drain current limited by maximum junction temperature.
- Mounted on FR4 Board of 1 inch² , 2oz.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS
